Notice of References Cited Application/Control No. 10/808,401 Examiner John L. Goodrow Applicant(s)/Patent Under Reexamination KOMOTO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0186152	10-2003	Ohno et al.	430/108.8
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